# onsemi

## **MOSFET** - Power, Single N-Channel

80 V, 3.2 mΩ, 135 A

# NVMFS6H818NL

#### Features

- Small Footprint (5x6 mm) for Compact Design
- Low RDS(on) to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFS6H818NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Para	Symbol	Value	Unit		
Fala	Symbol	value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	80	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current R <sub>θJC</sub>	Steady State	$T_{C} = 25^{\circ}C$	Ι <sub>D</sub>	135	А
(Notes 1, 3)	Siale	T <sub>C</sub> = 100°C		95	
Power Dissipation		$T_C = 25^{\circ}C$	PD	140	W
R <sub>θJC</sub> (Note 1)		$T_{C} = 100^{\circ}C$		70S	
Continuous Drain Current R <sub>0.IA</sub>	Steady State	T <sub>A</sub> = 25°C	Ι <sub>D</sub>	22	А
(Notes 1, 2, 3)	Siale	T <sub>A</sub> = 100°C		16	
Power Dissipation		T <sub>A</sub> = 25°C	PD	3.8	W
R <sub>θJA</sub> (Notes 1, 2)		$T_A = 100^{\circ}C$		1.9	
Pulsed Drain Current	$T_{A} = 25^{\circ}$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	772	А
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	– 55 to +175	°C
Source Current (Body Diode)			۱ <sub>S</sub>	116	А
Single Pulse Drain-to-Source Avalanche Energy ( $I_{L(pk)} = 9.3 A$ )			E <sub>AS</sub>	707	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

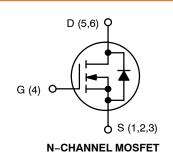
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	$3.2~\mathrm{m}\Omega$ @ 10 V	135 A
	4.1 mΩ @ 4.5 V	135 A

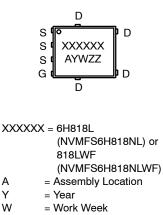




DFN5 (SO-8FL) CASE 488AA STYLE 1

DFNW5 (FULL-CUT SO8FL WF) CASE 507BA

#### MARKING DIAGRAM



ZZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

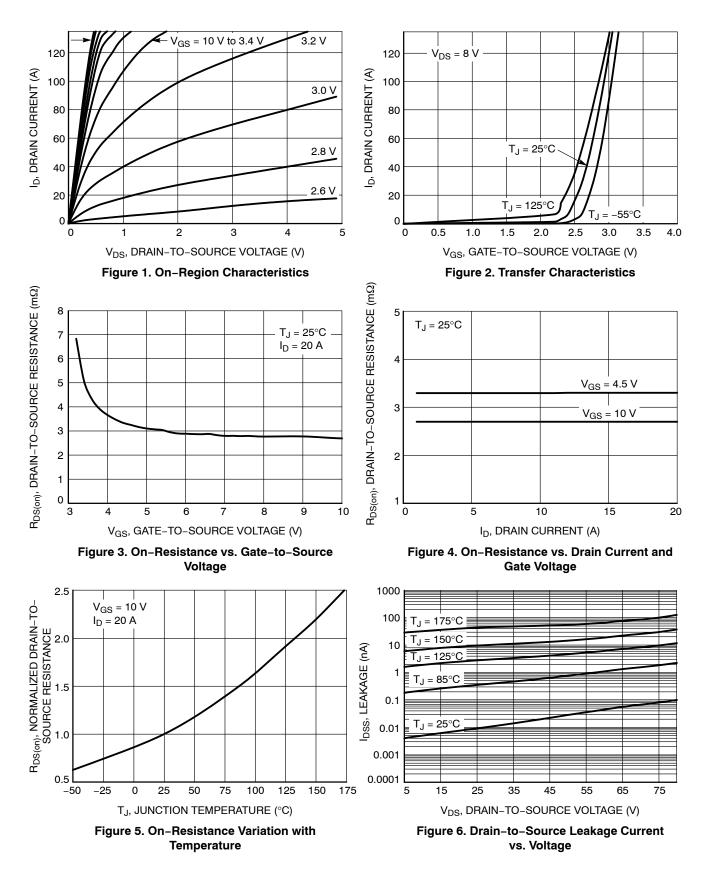
Downloaded from Arrow.com.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

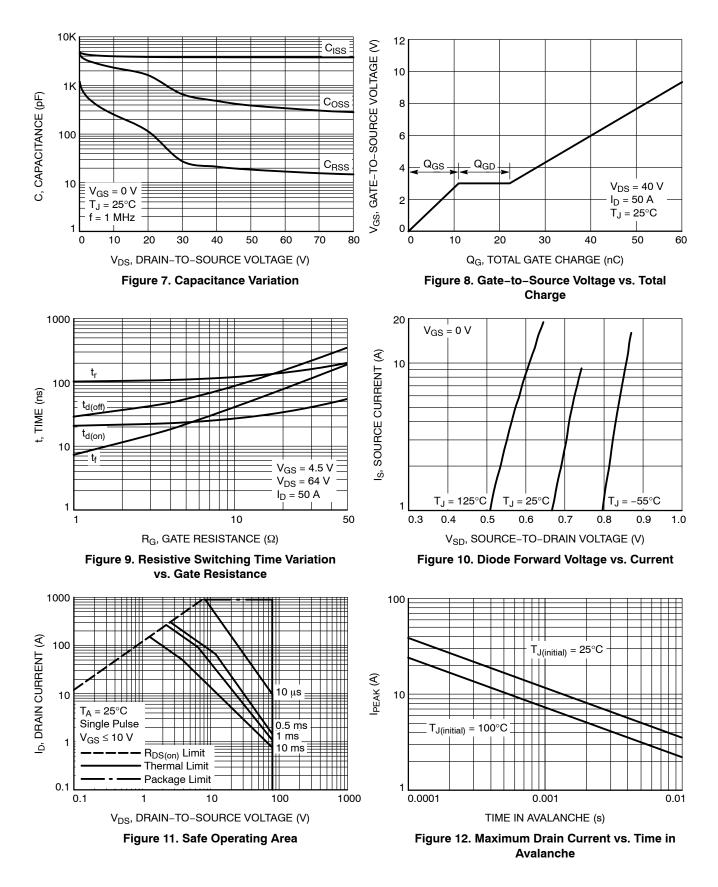
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				44.6		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25 °C			10	μA
		V <sub>DS</sub> = 80 V	$T_{\rm J} = 125^{\circ}C$			100	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)					-		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = 190 \ \mu A$		1.2		2.0	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.3		mV/°
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 20 A		2.7	3.2	mΩ
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 20 A		3.3	4.1	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 8 V, I <sub>D</sub> = 50 A			200		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE					1	
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 40 V			3844		pF
Output Capacitance	C <sub>OSS</sub>				484		
Reverse Transfer Capacitance	C <sub>RSS</sub>				21		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 40 V; I <sub>D</sub> = 50 A			64		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 40 V; $I_{D}$ = 50 A			6		-
Gate-to-Source Charge	Q <sub>GS</sub>				11		
Gate-to-Drain Charge	Q <sub>GD</sub>				11.2		
Plateau Voltage	V <sub>GP</sub>				3		V
Total Gate Charge	Q <sub>G(TOT)</sub>				31		nC
SWITCHING CHARACTERISTICS (Note 5						1	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 64 V, $I_{D}$ = 50 A, $R_{G}$ = 2.5 $\Omega$			22		ns
Rise Time	tr				106		-
Turn–Off Delay Time	t <sub>d(OFF)</sub>				39		
Fall Time	t <sub>f</sub>				13		
DRAIN-SOURCE DIODE CHARACTERIS	TICS	•			•		
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V,$ $I_{S} = 20 A$	$T_J = 25^{\circ}C$		0.77	1.2	V
			T <sub>J</sub> = 125°C		0.63		1
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 50 A			59		ns
Charge Time	t <sub>a</sub>				33		1
Discharge Time	t <sub>b</sub>				25		1
Reverse Recovery Charge	Q <sub>RR</sub>				73		nC

performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width  $\leq 300 \ \mu$ s, duty cycle  $\leq 2\%$ . 5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)



#### TYPICAL CHARACTERISTICS (continued)

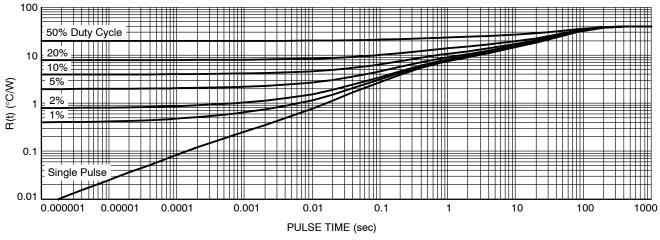


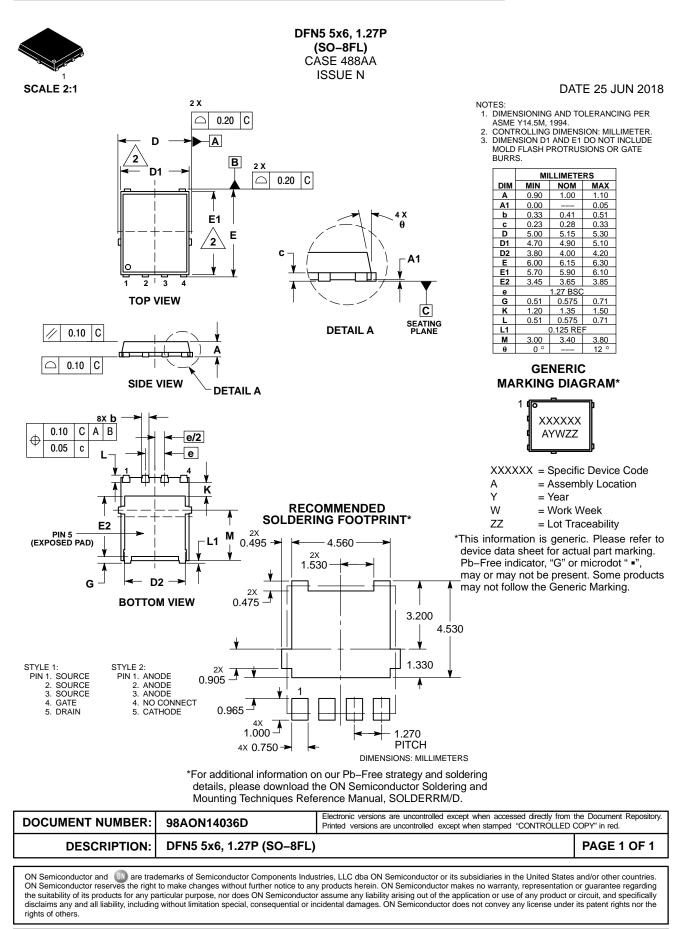
Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

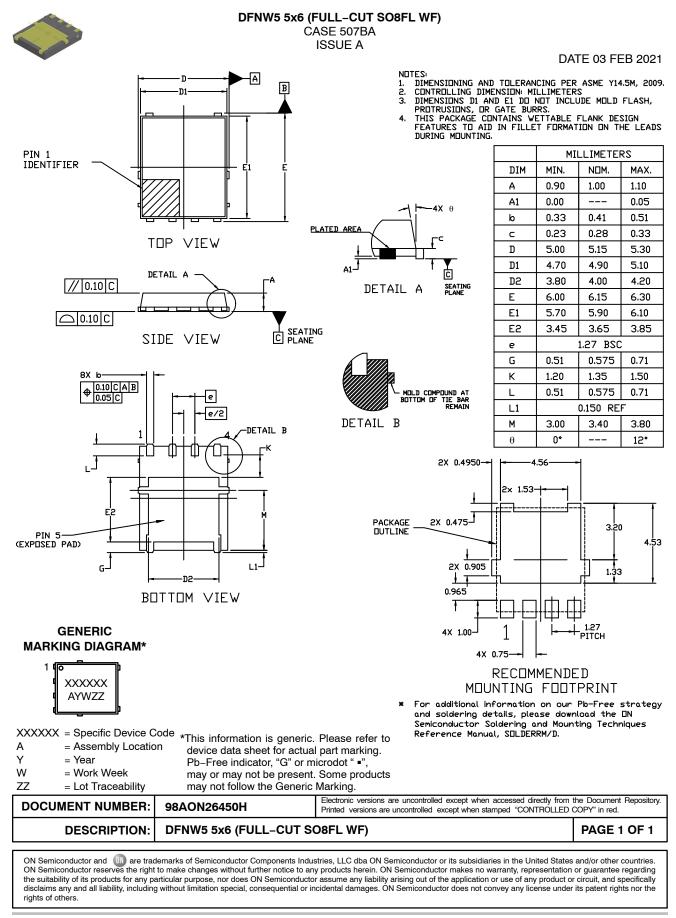
Device	Marking	Package	Shipping <sup>†</sup>
NVMFS6H818NLT1G	6H818L	DFN5 (Pb–Free)	1500 / Tape & Reel
NVMFS6H818NLWFT1G	818LWF	DFNW5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.









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